

Dual N-Channel Power MOSFET

30V, 51A, 8.5mΩ

FEATURES

- Low R_{DS(ON)} to minimize conductive losses
- Logic level
- Low gate charge for fast power switching
- 100% UIS and R_g Tested
- RoHS Compliant
- Halogen-free according to IEC 61249-2-21

KEY PERFORMANCE PARAMETERS				
PARAMETER		VALUE	UNIT	
V_{DS}		30	V	
R _{DS(on)} (max)	V _{GS} = 10V	8.5		
	$V_{GS} = 4.5V$	15	mΩ	
Q_g		10	nC	





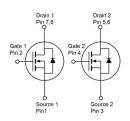


APPLICATIONS

- BLDC Motor Control
- Battery Power Management
- DC-DC Converter
- Secondary Synchronous Rectification

PDFN56 Dual





Note: MSL 1 (Moisture Sensitivity Level) per J-STD-020

PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain Current (Note 1)	$T_C = 25^{\circ}C$		51	
	$T_A = 25^{\circ}C$	I _D	12	A
Pulsed Drain Current		I _{DM}	204	А
Single Pulse Avalanche Current (Note 2)		I _{AS}	17	Α
Single Pulse Avalanche Energy (Note 2)		E _{AS}	43	mJ
Total Power Dissipation	$T_C = 25^{\circ}C$	Б	40	107
	T _C = 125°C	P _D	8	W
Total Power Dissipation	T _A = 25°C	D	2	107
	T _A = 125°C	P _D	0.4	W
Operating Junction and Storage Temperature Range		T_J, T_{STG}	- 55 to +150	°C

THERMAL PERFORMANCE				
PARAMETER	SYMBOL	MAXIMUM	UNIT	
Junction to Case Thermal Resistance	R _{eJC}	3.1	°C/W	
Junction to Ambient Thermal Resistance	$R_{\Theta JA}$	61	°C/W	

Thermal Performance Note: $R_{\Theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistances. The case-thermal reference is defined at the solder mounting surface of the drain pins. $R_{\Theta JC}$ is guaranteed by design while $R_{\Theta CA}$ is determined by the user's board design. The $R_{\Theta JA}$ limit presented here is based on mounting on a 1 in² pad of 2 oz copper.

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PARAMETER	CONDITIONS	SYMBOL	MIN	TYP	MAX	UNIT
Static						•
Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	BV _{DSS}	30			V
Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	$V_{GS(TH)}$	1.3	1.8	2.5	V
Gate-Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	I _{GSS}			±100	nA
	$V_{GS} = 0V, V_{DS} = 30V$				1	μA
Drain-Source Leakage Current	$V_{GS} = 0V, V_{DS} = 30V$ $T_{J} = 125^{\circ}C$	I _{DSS}			100	
Drain-Source On-State Resistance	$V_{GS} = 10V, I_D = 12A$			6.5	8.5	mΩ
(Note 3)	$V_{GS} = 4.5V, I_D = 9A$	$R_{DS(on)}$		11	15	
Forward Transconductance (Note 3)	$V_{DS} = 10V, I_{D} = 12A$	g _{fs}		30		S
Dynamic (Note 4)						
Total Gate Charge	$V_{GS} = 10V, V_{DS} = 15V,$ $I_{D} = 12A$	Q_g		20		
Total Gate Charge	$V_{GS} = 4.5V, V_{DS} = 15V,$ $I_{D} = 9A$	Q_g		10		nC
Gate-Source Charge		Q _{gs}		4		1
Gate-Drain Charge		Q_{gd}		5		
Input Capacitance	$V_{GS} = 0V, V_{DS} = 15V,$ f = 1.0MHz	C _{iss}		1091		
Output Capacitance		C _{oss}		176		pF
Reverse Transfer Capacitance		C _{rss}		106		
Gate Resistance	f = 1.0MHz	R_g	0.6	2	4	Ω
Switching (Note 4)						
Turn-On Delay Time		t _{d(on)}		4		
Turn-On Rise Time	$V_{GS} = 10V, V_{DS} = 15V,$ $I_D = 12A, R_G = 2\Omega$	t _r		6		
Turn-Off Delay Time		t _{d(off)}		14		ns
Turn-Off Fall Time		t _f		5		
Source-Drain Diode						
Forward Voltage (Note 3)	$V_{GS} = 0V, I_{S} = 12A$	V_{SD}			1	V
Reverse Recovery Time	I _S = 12A,	t _{rr}		13		ns
Reverse Recovery Charge	dl/dt = 100A/µs	Q _{rr}		4		nC

Notes:

- 1. Silicon limited current only.
- 2. L = 0.3mH, $V_{GS} = 10$ V, $V_{DD} = 25$ V, $R_G = 25\Omega$, $I_{AS} = 17$ A, Starting $T_J = 25$ °C
- 3. Pulse test: Pulse Width \leq 300 μ s, duty cycle \leq 2%.
- 4. Switching time is essentially independent of operating temperature.

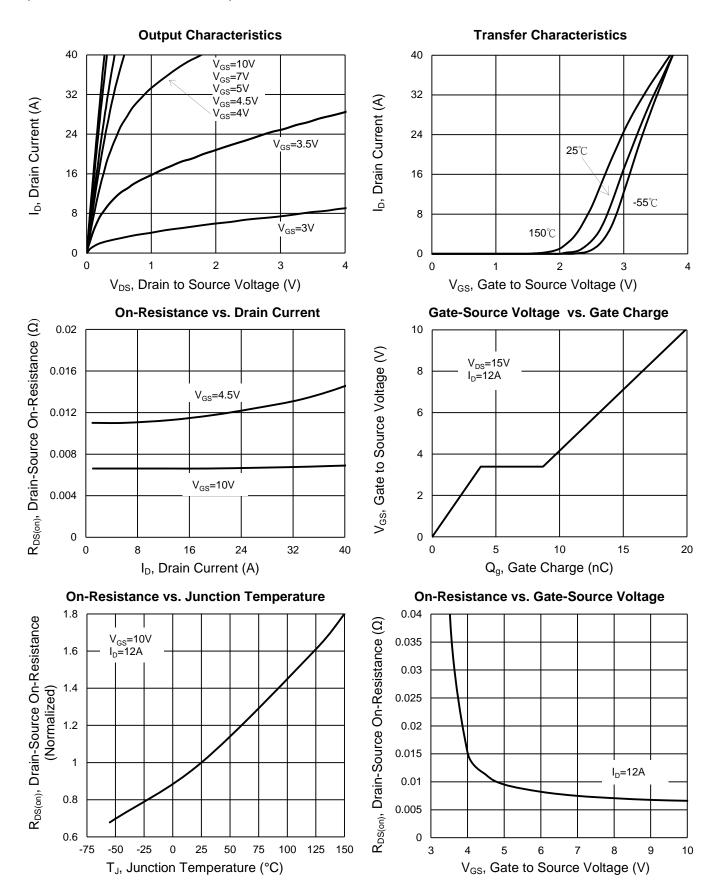
ORDERING INFORMATION

ORDERING CODE	PACKAGE	PACKING
TSM085NB03DCR RLG	PDFN56 Dual	2,500pcs / 13" Reel



CHARACTERISTICS CURVES

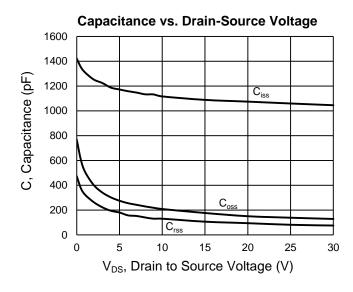
 $(T_A = 25^{\circ}C \text{ unless otherwise noted})$

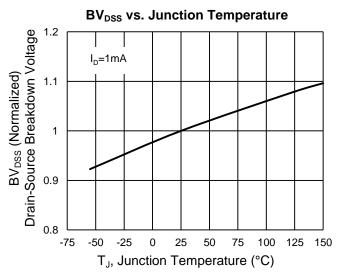




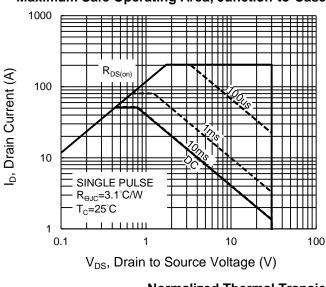
CHARACTERISTICS CURVES

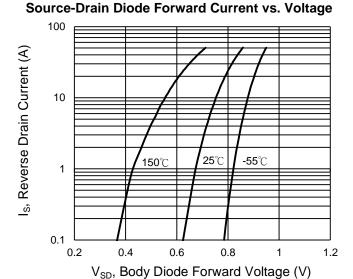
 $(T_A = 25^{\circ}C \text{ unless otherwise noted})$



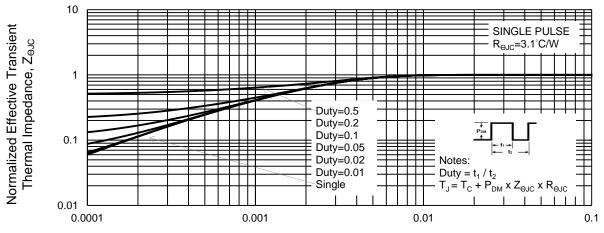


Maximum Safe Operating Area, Junction-to-Case 1000





Normalized Thermal Transient Impedance, Junction-to-Case



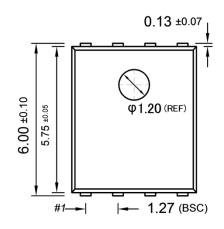
t, Square Wave Pulse Duration (sec)

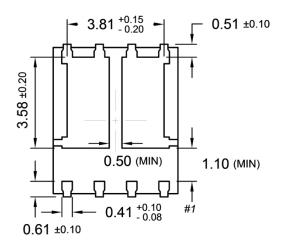


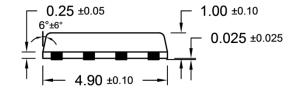
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PACKAGE OUTLINE DIMENSIONS (Unit: Millimeters)

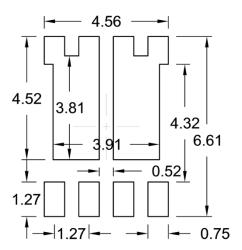
PDFN56 Dual







SUGGESTED PAD LAYOUT (Unit: Millimeters)



MARKING DIAGRAM



Y = Year Code

WW = Week Code (01~52)

L = Lot Code (1~9,A~Z)

F = Factory Code



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